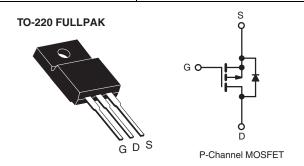


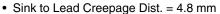
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	0.20		
Q _g (Max.) (nC)	61			
Q _{gs} (nC)	14			
Q _{gd} (nC)	29			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)





- P-Channel
- 175 °C Operating Temperature
- Dynamic dV/dt
- · Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION			
Package	TO-220 FULLPAK		
Lead (Pb)-free	IRFI9540GPbF		
Lead (Fb)-liee	SiHFI9540G-E3		
SnPb	IRFI9540G		
OIII D	SiHFI9540G		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 100	V	
Gate-Source Voltage			V_{GS}	± 20] v	
Continuous Drain Current	V at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	I _D	- 11	А	
	VGS at - 10 V			- 7.6		
Pulsed Drain Current ^a			I _{DM}	- 44		
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	600	mJ	
Repetitive Avalanche Currenta			I _{AR}	- 11	А	
Repetitive Avalanche Energy ^a			E _{AR}	4.8	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	48	W	
Peak Diode Recovery dV/dtc			dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10	s	-	300 ^d		
Mounting Torque	6 20 or M0	6-32 or M3 screw		10	lbf ⋅ in	
	6-32 OF M3 SCIEW			1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 7.4 \,\text{mH}$, $R_G = 25 \,\Omega$, $I_{AS} = -11 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le$ 19 A, $dI/dt \le$ 170 A/µs, $V_{DD} \le V_{DS}$, $T_J \le$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	- 100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	-	- 0.087	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA		- 2.0	-	- 4.0	٧
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V		-	± 100	nA
Zana Cata Valtana Darin O		V _{DS} =	V _{DS} = - 100 V, V _{GS} = 0 V		-	- 100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 80 V	', V _{GS} = 0 V, T _J = 150 °C	-	-	- 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 6.6 A ^b	-	-	0.20	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	V _{DS} = - 50 V, I _D = - 6.6 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	1400	-	pF
Output Capacitance	C _{oss}			-	590	-	
Reverse Transfer Capacitance	C _{rss}			-	140	-	
Drain to Sink Capacitance	С		f = 1 MHz	-	12	-	
Total Gate Charge	Qg		I _D = - 19 A, V _{DS} = - 80 V, see fig. 6 and 13 ^b	-	-	61	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		-	-	14	
Gate-Drain Charge	Q _{gd}	1		-	-	29	
Turn-On Delay Time	t _{d(on)}				24	-	- ns
Rise Time	t _r	$V_{DD} = -50 \text{ V}, I_D = -19 \text{ A}, \\ R_G = 9.1 \Omega, R_D = 7.4 \Omega, \\ \text{see fig. } 10^b$		-	110	-	
Turn-Off Delay Time	t _{d(off)}			-	51	-	
Fall Time	t _f			-	86	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	1			I.		<u> </u>
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol showing the		-	- 11	- A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 44	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = - 11 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	- 4.2	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = -19 A, dl/dt = 100 A/μs ^b		-	130	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.35	0.70	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

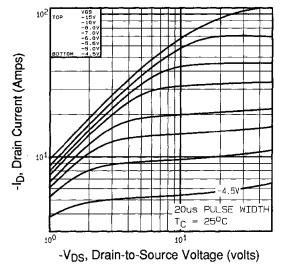


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

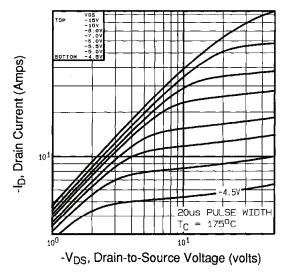


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

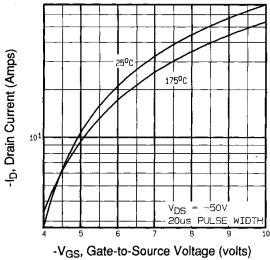


Fig. 3 - Typical Transfer Characteristics

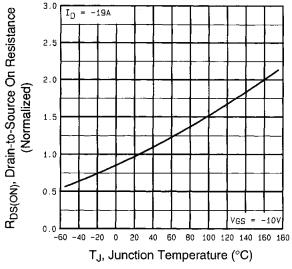


Fig. 4 - Normalized On-Resistance vs. Temperature



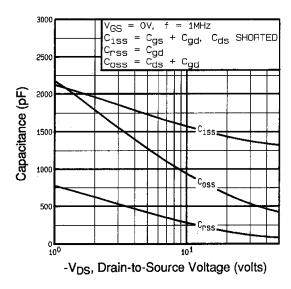


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

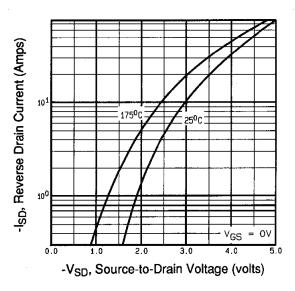


Fig. 7 - Typical Source-Drain Diode Forward Voltage

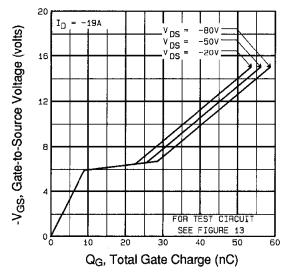


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

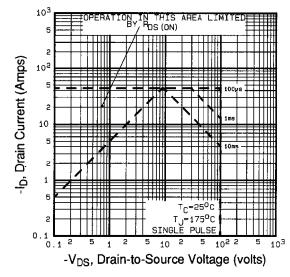


Fig. 8 - Maximum Safe Operating Area

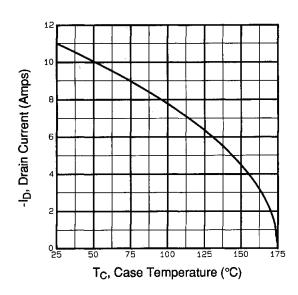


Fig. 9 - Maximum Drain Current vs. Case Temperature

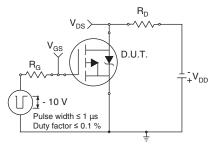


Fig. 10a - Switching Time Test Circuit

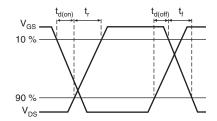


Fig. 10b - Switching Time Waveforms

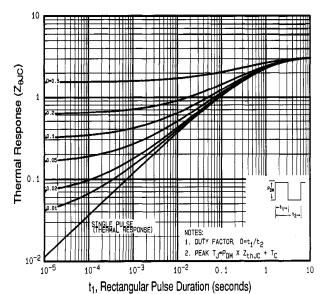


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

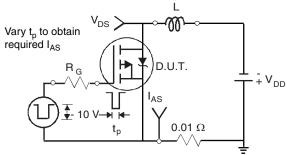


Fig. 12a - Unclamped Inductive Test Circuit

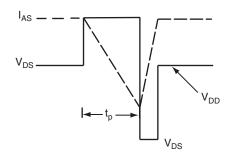
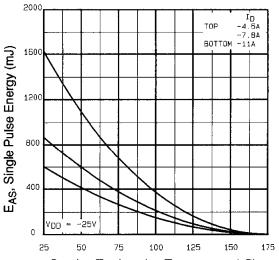


Fig. 12b - Unclamped Inductive Waveforms





 $Starting \ T_J, \ Junction \ Temperature (^\circ C)$ Fig. 12c - Maximum Avalanche Energy vs. Drain Current

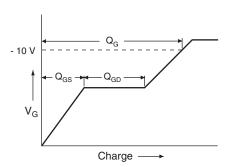


Fig. 13a - Basic Gate Charge Waveform

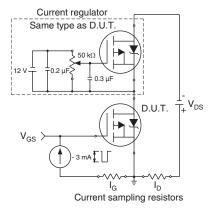
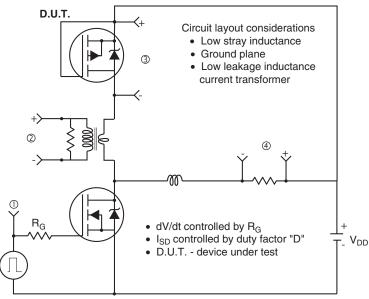


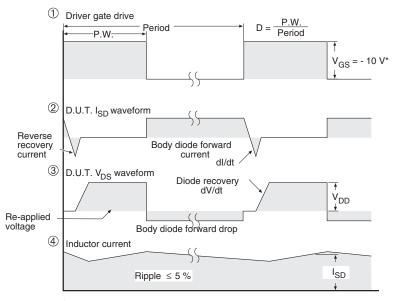
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



* $V_{GS} = -5$ V for logic level and -3 V drive devices Fig. 14 - For P-Channel

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